Date Mailed: November 10, 2004

Sheet 1 of 1

FORM 1449* INFORMATION DISCLOSURE STATEMENT	Docket Number: Application Number: 12364.28USU1 10/056,226				
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FORM 149-P INFORMATION DISCLOSURE STATEMENT	Docket Number: 12364.0028USU1			
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(Use several sheets if necessary)	Filing Date: January 23, 2002	Group Art Unit: 2821 2828		
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